

ICEP-IAAC 2018 Advance Program

April 17 Tuesday

A	
13:30	<p>Global Business Council “New Era of Automotive Electronics”</p> <p>1. Automotive Design Based on Sensibility Study of Brain Activity [Provisional] Kazuo Nishikawa, Mazda Motor</p> <p>2. Automotive Electronics Evolves Automobile!? Nobuaki Kawahara, DENSO</p> <p>3. SiC solutions for eMobility Akifumi Enomoto, ROHM Semiconductor</p>
15:00	
Break	
15:15	<p>4. Integrated Intelligent Transportation & Key Enablers Dwight Howard, Delphi Automotive Systems</p> <p>5. Artificial Intelligence and Automotive Manufacturing Bill Cardoso, Creative Electron</p> <p>6. Automotive Electronics are Driving Innovation in Electronic Materials, Processes and Packaging Technologies Rozalia Beica, The Dow Chemical</p> <p>7. What 2D and 3D (CT) X-Ray Inspection Now Provides for Electronics in Automotive Environments David Bernard, David Bernard Consultancy</p>
17:15	
17:45	
19:15	Party

April 18 Wednesday

A	
10:00	Opening
10:20	
10:20	<p>Keynote Lecture Future Prospect for Semiconductor Technologies Supporting Automotive “Intelligence” and “Electrification” Kiminori Hamada, Toyota Motor</p>
11:20	
11:20	<p>Keynote Lecture Challenges and Opportunities in Gen3 Embedded Cooling with High Quality Microgap Flow Avram Bar-Cohen, Raytheon</p>
12:20	
12:20	Lunch Time
13:30	
13:30	Greeting
13:35	
13:35	Ceremony
14:10	
14:10	<p>Keynote Lecture A New Neurofeedback Based Cognitive Training with Ultra-small NIRs System Ryuta Kawashima, Tohoku University</p>
15:10	
15:10	Poster Session / Break
16:10	
16:10	<p>Keynote Lecture Magnetism and Superconductivity Kazuyoshi Yoshimura, Kyoto University</p>
17:10	
17:10	

Keynote Lecture
Current Status and Trends of IC Packaging in China
 Tianchun Ye, Institute of Microelectronics of Chinese Academy of Sciences

18:10

18:10

18:20

18:30

20:30

Introduction of Future Events

Welcome Reception
 Hotel Hanamizuki

April 19 Thursday

	A	B	C	D	
9:00	TA1: Korea Session-1 TA1-1 <Session Invited> Multiple Plasma System for Panel Level Package Gusung Kim, Kangnam University / Korea TA1-2 <Session Invited> PCB Material Property Effects on PBGA Reliability Yeong K. Kim ¹ , Dong Yeong Kim ¹ , Hyun Soo Park ¹ , Do Soon Hwang ² , Young Sik Boo ³ , ¹ Inha University, ² Korea Aerospace Research Institute, ³ Korea Aerospace Industries / Korea TA1-3 <Session Invited> Intermetallic Compound Formation and Mechanical Property of Sn-Cu-xCr/Cu Lead-free Solder Join Junghwan Bang ¹ , Dong-Yurl Yu ¹ , Yong-Ho Ko ¹ , Sehoon Yoo ¹ , Hiroshi Nishikawa ² , Chang-Woo Lee ¹ , ¹ Institute of Industrial Technology / Korea, ² Osaka University / Japan TA1-4 <Session Invited> Electrochemical Etching Behavior of Copper and Invar for Metal Core PCB Application Jae-Ho Lee, Yongsu Lee, Hongik University	TB1: Advanced Packaging-1 TB1-1 <Session Invited> 3D IPD Teck Lee, ASE Group / Taiwan TB1-2 Development of the Integrated Passive Device using Through-Glass-Via substrate Jun Onohara ¹ , Fusao Takagi ¹ , Takashi Kizu ¹ , Koji Imayoshi ¹ , Hironori Nomura ¹ , Hobie Yun ² , ¹ Toppan Printing / Japan, ² Qualcomm Technologies / USA TB1-3 Wafer Level 3D Stacked Technology Solution for Future IoT Devices. Takahide Murayama, Toshiyuki Sakuishi, Akiyoshi Suzuki, Yasuhiro Morikawa, ULVAC / Japan TB1-4 Application-oriented Wear-leveling Optimization of 3D TSV-integrated Storage Class Memory-based Solid State Drives Masaru Nakanishi, Yutaka Adachi, Chihiro Matsui, Yusuke Sugiyama, Ken Takeuchi, Chuo University / Japan	TC1: Materials and Processes: plating tech TC1-1 Effects of Plating Conditions on Electroless Ni-P Plating in the Microchannel Ching-Yun Yang, Han-Tang Hung, C. Robert Kao, National Taiwan University / Taiwan TC1-2 Effect on Film Properties by Phosphorus and Sulfur Content Rate in Electroless Ni-P Plating Films Norihiko Hasegawa, Kei Hashizume, Junichi Katayama, Okuno Chemical Industries / Japan TC1-3 Insulation Reliability of Electric Circuit Fabricated with Nano-Silver Plating Catalyst Norimasa Fukazawa, Wataru Fujikawa, Yoshinari Santou, Jun Shirakami, DIC / Japan TC1-4 Bonding of Copper Pillars using Electroless Au Plating I-An Weng, Han-Tang Hung, Sean Yang, Ying-Hsuan Chen, C. Robert Kao, National Taiwan University / Taiwan	TD1: Medical & Healthcare-1 TD1-1 <Session Invited> Wearables and Implantables : How technology transforms health care--and how health care transforms the technology business Matthew K. Hudes, bdlBilologx / USA TD1-2 <Session Invited> Non-invasive Biosensing Devices for Preemptive Medicine Kohji Mitsubayashi, Tokyo Medical and Dental University / Japan TD1-3 Practical Realization of Enfold Connecting System of Artificial Blood Vessel for Simplifying Maintenance Surgery Evaluation of Thrombus Formation and Blood Coagulation Capacity Ai Watanabe ¹ , Takashi Ota ¹ , Y. Kanno ² , Norihisa Miki ¹ , ¹ Keio university, ² Tokyo Medical University / Japan TD1-4 Development of Multi-lead ECG Measurement Wear using Electrostatic Flocking Technology Toshihiro Takeshita ¹ , Manabu Yoshida ¹ , Atsushi Ouchi ¹ , Akinari Hinoki ² , Hiroo Uchida ² , Takeshi Kobayashi ¹ , ¹ National Institute of Advanced Industrial Science and Technology, ² Nagoya University / Japan	TE1: Design, TE1-1 Evaluation of Cu Metalized Raman Spectroscopy Kiyoshi Hiraoka, Miyazaki ¹ , Y. Iwakiri ² , ¹ National Institute of Industrial Science and Technology Japan TE1-2 Electric Current Deformation Yu-chen Liu, S. Kung University TE1-3 High Spatial-Resolution by Pixelated S Sho Miyao, Ta Fujioka, Izumi Haruhito Kodama, Shigeta, Toray TE1-4 Investigation of Accelerated I Raphael Pihet, Yuichi Aoki, E
Break					
>10:50	TA2: Korea Session-2 TA2-1 <Session Invited> Fabrication of Ag Nano Composite Paste and Its Characteristics Seung-Boo Jung ¹ , Bum-Geun Park ¹ , Kwang-Seok Kim ² , Daeup Kim ² , ¹ Sungkyunkwan University, ² Korea Institute of Industrial Technology / Korea TA2-2 <Session Invited> Aerogels for Interlayer Low Dielectric of Semiconductor Devices Hyung-Ho Park, Kyu-Yeon Lee, Tae-Hee Kim, Haryeong Choi, Yonsei University / Korea TA2-3 <Session Invited> Strategies for Improving Mechanically Reliability of Thin-Film Flexible Electronics Taek-Soo Kim, Korea Advanced Institute of Science and Technology / Korea	TB2:Advanced Packaging-2 TB2-1 Study on Silicon Device of Microrobot System for Heterogeneous Integration Ken Saito ^{1,2} , Daniel S. Contreras ² , Yudai Takeshiro ³ , Yuki Okamoto ³ , Yuya Nakata ¹ , Taisuke Tanaka ¹ , Satoshi Kawamura ¹ , Taisuke Tanaka ¹ , Minami Kaneko ¹ , Fumio Uchikoba ¹ , Yoshio Mita ³ , Kristofer S. J. Pister ² , ¹ Nihon University / Japan, ² University of California / USA, ³ The University of Tokyo / Japan TB2-2 Ultra-Slim Package Design for Millimeter Wave Application Ming-Fong Jhong ¹ , Chung-Hsiung Ho ² , Wen-Hsuan Lin ² , Chih-Yi Huang ¹ , Po-Chih Pan ¹ , Chen-Chao Wang ¹ , ¹ Advanced Semiconductor Engineering, ² NXP Semiconductors / Taiwan TB2-3 Novel Plating Photoresist Development for Advanced Packaging Rui Li, Tomoyuki Matsumoto, Takuhiro Taniguchi, Naoki Nishiguchi, Akito Hiro, Hirokazu Sakakibara, Koichi Hasegawa, JSR / Japan TB2-4 Laser Micro-machining of LPM Compound Material for Panel and IC Packaging	TC2: Materials and Processes: solder materials TC2-1 Considerations on Selection of Alloying Elements for Designing Sn-based Solder Alloys by the Molecular Orbital Method Wataru Takahara, Osaka University / Japan TC2-2 Effect of Reflow Conditions on the Intermetallic Layer in Solder Joints Kazuhiro Nogita ¹ , Flora Somidin ^{1,2} , Arif Salleh ^{1,2} , Keith Sweatman ³ , Tetsuro Nishimura ³ , Stuart McDonald ¹ , Hiroshi Maeno ⁴ , Syo Matsumura ⁴ , ¹ The University of Queensland / Australia, ² Universiti Malaysia Perlis / Malaysia, ³ Nihon Superior, ⁴ Kyushu University / Japan TC2-3 Investigation of the Interfacial Reactions and Mechanical Strength in the Sn-Ag-Cu (SAC)/ Cu-Be Alloy (Alloy25) Couple Jing-Shiun Chang, Yee-Wen Yen, National Taiwan University of Science and Technology / Taiwan TC2-4 Solder Electromigration Failure Time as a Function of the Angle Between the c-axis of Sn Crystals and Direction of Electron Flow Tsubasa Sakai, Eishi Watanabe, Tsubasa Sei, Kimihiro Yamanaka, Chukyo University / Japan	TD2: Emerging Technologies-1 TD2-1 <Session Invited> On-demand Full Additive Manufacturing of Electronic Devices applying Inkjet Technology Ryojiro Tominaga, Takeshi Sato, Kenji Tsukada, Akihiro Kawajiri, Katsuaki Makihara, Yoshitaka Hashimoto, Shigeyoshi Inagaki, FUJI Machine Mfg. / Japan TD2-2<Session Invited> Advanced FPGA Technology Trend based on Patent Analysis with Link Mining Masashi Shibata, Yuichi Ohtsuka, Masakazu Takahashi, Kazuya Okamoto, Yamaguchi University / Japan TD2-3 Deep Learning Consideration with Novel Approach: look-up-table based processing conjugated memory Kanji Otsuka, Yoichi Sato, Meisei University / Japan TD2-4 A Study on Application of Artificial Intelligence (AI) for Cosmetics: Quantum computer is necessary for Beauty-field analysis Yasuo Kato, SHISEIDO / Japan	TE2: Design, TE2-1 Optimization of 0.7Cu-xNi-yB Interconnects Sergey Belyakov, Tetsuya Akaishi, Nogita ³ , Chris College London Japan, ³ Univer TE2-2 Analysis of the Initiation in S LEDs Ping Xu ¹ , Ron Michael Kalou ¹ University of Deutschland, ³ Aschaffenburg TE2-3 Creep Mechanical Orientation of Nanoindentation Po-Jung Chian, C. Robert Kao Taiwan TE2-4 The Failure Mechanism of Ag-Cu Solder Tests Ting Chun Lin

12:30		Wen-Fei Lin ¹ , Shih-Jeh Wu ¹ , Hsiang-Chen Hsu ^{1,2} , Boen Houng ¹ , Min-Shuo Chen ¹ , ¹ I-Shou University, ² St. John's University / Taiwan			Lee ¹ , Ming H...
	Lunch Time				
13:30	<p>TA3: Taiwan Session TA3-1 <Session Invited> Sintered Silver-Indium Bonding with Anti-oxidation Property for High Temperature Applications C Robert Kao, C A Yang, National Taiwan University / Taiwan</p> <p>TA3-2 <Session Invited> Thermal Strategy for 2.5D IC High Power Application Tang-Yuan Chen, Jin-Feng Yang, Meng-Kai, Shih, David Tarng, Chih-Pin Huang, Advanced Semiconductor Engineering / Taiwan</p> <p>TA3-3 <Session Invited> Low Temperature Bonding Technology for 3D Integration and Advanced Packaging Kuan-Neng Chen, National Chiao Tung University / Taiwan</p>	<p>TB3: Advanced Packaging-3 TB3-1 Effect of Substrate Surface Finish on Bonding Strength of Pressure-less Sintered Silver Die-attach Meiyu Wang^{1,2}, Yunhui Mei¹, Rolando Burgos², Dushan Boroyevich², Guo-Quan Lu^{1,2}, ¹Tianjin University / China, ²Virginia Tech / USA</p> <p>TB3-2 Ag Joint Bonding Technology for Bare Copper Substrate in Low Temperature, Pressureless and Air Condition Zheng Zhang, Chuantong Chen, Hao Zhang, Shijo Nagao, Katsuaki Suganuma, Osaka University / Japan</p> <p>TB3-3 Interfacial Reactions between Sn and Au-xCu Alloys Chih-Hung Lin, Chia-Yi Yeh, Yee-Wen Yen, National Taiwan University of Science and Technology / Taiwan</p>	<p>TC3: Materials and Processes: micro / nano silver relating tech TC3-1 Sprayable Silver Paste with Good Shielding Characteristics in the High Frequency Band Takashi Sakamoto, Daisuke Hashimoto, Namics / Japan</p> <p>TC3-2 Ultra-fine Patterning Technology by Utilizing Nano-silver Catalysts in MSAP Yuhei Kitahara, Joonhaeng Kang, Okuno Chemical Industries / Japan</p> <p>TC3-3 Effect of Pre-annealing of Au Metallization Structure on the Bonding Performance with Low Temperature Pressureless Sintering Ag Chuantong Chen¹, Zheng Zhang¹, Shijo Nagao¹, Katsuaki Suganuma¹, Tomohito Iwashige², Kazuhiko Sugiura², Kazuhiro Tsuruta², ¹Osaka University, ²Denso / Japan</p> <p>TC3-4 Sintering Mechanism of Micron/submicron-size Silver Particles Jeyun Yeom, Cai-Fu Li, Katsuaki Suganuma, Osaka University/ Japan</p>	<p>TD3: High-Speed, Wireless & Components-1 TD3-1 <Session Invited> (50min.) High Speed Vertical Interconnect Analysis for Dense Pin Assignment Optimization using Electromagnetic Multiple Scattering Techniques Boping Wu, Huawei Technologies / China</p> <p>TD3-2 43 % Reduced Program Time, 23 % Energy Efficient ReRAM Boost Converter with PMOS Switching Transistor and Boosted Buffer Circuit for ReRAM and NAND Flash Hybrid SSDs Kenta Suzuki, Masahiro Tanaka, Kota Tsurumi, Ken Takeuchi, Chuo University / Japan</p> <p>TD3-3 Design of Transmission Line with Impedance Resonator for Negative Group Delay and Slope Characteristics by Preference Set-based Design Method Yoshiki Kayano, Yoshio Kami, Haruo Ishikawa, Fengchao Xiao, Hiroshi Inoue, The University of Electro-Communications / Japan</p>	<p>TE3: Battery M... TE3-1 Multilayer Co... Battery Tomohiko Kor... Japan</p> <p>TE3-2 Synthesize of... 3D Nano-stru... for Sodium Io... Naoki Okamo... Morita, Takey... University / Ja...</p> <p>TE3-3 Handling of C... Substrates fo... Messaoud Bec... Poulet, Nicol... Université Gre...</p> <p>TE3-4 Evaluating M... Electrolyte M... Akira Ueno, T... Takakura, Gue... University / Ja...</p>
15:10					
	Poster Session / Break				
16:10	<p>TA4: iNEMI Session TA4-1 <Session Invited> iNEMI Project Overview: characterize and quantify the production inspection capability of AXI for HiP defects Ayman Fayed, Intel / USA</p> <p>TA4-2 SiP Module Mold Flowability Experiment Result and Simulation Study Yonghyuk Jeong¹, Billy Ahn¹, Jim Hsu², Anthony Yang², Tetsuya Koyama³, Kiyoshi Oi³, Jeffrey Lee⁴, Takahiro Horie⁵, Masahiro Tsuriya⁶, ¹STATSChipPAC / Korea, ²CoreTech System (Moldex3D) / Taiwan, ³Shinko Electric Industries / Japan, ⁴Integrated Service Technology / Taiwan, ⁵Hitachi Chemical, ⁶iNEMI / Japan</p> <p>TA4-3 SiP Module Warpage Characterization and Simulation Study Jim Hsu¹, Anthony Yang¹, Yonghyuk Jeong², Billy Ahn², Tetsuya Koyama³, Kiyoshi Oi³, Jeffrey Lee⁴, Takahiro Horie⁵, Masahiro Tsuriya⁷, ¹CoreTech System (Moldex3D) / Taiwan, ²STATSChipPAC / Korea, ³Shinko Electric Industries / Japan, ⁴Integrated Service Technology / Taiwan, ⁵Hitachi Chemical, ⁶iNEMI / Japan</p> <p>TA4-4 iNEMI Project on Process Development of BiSn-Based Low Temperature Solder Pastes - Part III: mechanical shock tests on PoP BGA assemblies Haley Fu¹, Jagadeesh Radhakrishnan², Morgana Ribas³, Raiyo Aspandiar², Kevin Byrd², Jimmy Chen⁴, Shunfeng Cheng², Qin Chen⁵, Richard Coyle⁶, Sophia Feng⁷, Mark Krmpotich⁸, Scott Mokler², Brook Sandy-Smith⁹, Kok Kwan Tang¹⁰, Greg Wu¹¹, Anny Zhang⁹, Wilson Zhen¹² ¹iNEMI / China, ²Intel / USA, ³Alpha Assembly Solutions / India, ⁴Flex / China, ⁵Eunow / China, ⁶Nokia / US, ⁷Celestica / China, ⁸Microsoft / USA, ⁹Indium / USA,</p>	<p>TB4: Materials for Organic Semiconductor Devices TB4-1 Printable Electronic Circuits Based on Metal Nanoparticles and Organic Semiconductors Takeo Minari¹, Xuying Liu¹, Masayuki Kanehara², ¹NIMS, ²C-INK / Japan</p> <p>TB4-2 <Session Invited> Key Factor of Conductive Nanoink Design for High Performance Printed Devices Masayuki Kanehara, C-INK / Japan</p> <p>TB4-3 <Session Invited> High-yield Flexible Organic Complementary Circuits Integrated with Sensors Mayumi Uno, Osaka Research Institute of Science and Technology / Japan</p> <p>TB4-4 Design and Fabrication of Photo-sensitive Thin-film Transistors with IGZO and Organic Photo-absorber Zhaogui Wang¹, Yongfeng Zheng¹, Xuhong Cao¹, Hang Zhou², Chuan Liu¹, ¹Sun Yat-sen University, ²Peking University / China</p>	<p>TC4: Materials and Processes: thermal solution TC4-1 Extreme Low Interfacial Thermal Resistance Heat Conductive Sheet Masao Tomikawa, Akira Shimada, Toray Industries / Japan</p> <p>TC4-2 Development of Low Temperature Solder Alloys for Advanced Electronic Packaging - assessment of In-Bi alloys on Cu substrates Albert T. Wu¹, Chih-Hao Chen¹, Jyun-Jhe Huang¹, Jeng-Yu Chiang¹, Chang-Meng Wang², ¹National Central University, ²SHENMAO Technology / Taiwan</p> <p>TC4-3 Measurement of Thermal and Electrical Contact Resistance Between Conductive Materials Yoshiki Hyodo¹, Tomoyuki Hatakeyama¹, Risako Kibushi², Masaru Ishizuka¹, ¹Toyama Prefectural University, ²Tokyo University of Science Yamaguchi / Japan</p> <p>TC4-4 Process Evaluation of Pyramidal and Cone-shaped Nanoparticle Deposition (NPD) Bumps using a Thermally Resistant Resist Ying Ying Lim, Masaru Hashino, Hiroshi Nakagawa, Masahiro Aoyagi, Katsuya Kikuchi, National Institute of Advanced Industrial Science and Technology / Japan</p>	<p>TD4: High-Speed, Wireless & Components-2 TD4-1 Antenna on Glass for 60GHz WiGig Application Ching Kuan Lee¹, Yung Jean (Rachel) Lu², Hsiang-Hung Chang¹, Li-Chi Chang¹, Chang-Sheng Chen¹, ¹Industrial Technology Research Institute, ²Corning / Taiwan</p> <p>TD4-2 Design and Demonstration of Ultra-thin 3D Glass-based 5G Modules with Low-loss Interconnections Atom O. Watanabe¹, Tong-Hong Lin¹, Tomonori Ogawa², P. Markondeya Raj¹, Venkatesh Sundaram¹, Manos M. Tentzeris¹, Rao R. Tummala¹, ¹Georgia Institute of Technology / USA, ²Asahi Glass / Japan</p> <p>TD4-3 Experimental Study of Through Glass Via Effects on High Frequency Electrical Characteristics Masaya Tanaka¹, Yumi Okazaki¹, Junichi Suyama¹, Satoru Kuramochi¹, Youggun Han², Osamu Horiuchi², Yoshihisa Kato², ¹Dai Nippon Printing, ²Fukuoka University / Japan</p> <p>TD4-4 Experimental Investigation of Wireless Energy Harvesting with a Bluetooth Low Energy Sensing Unit Mohamed M. Mansour^{1,4}, Osamu Takiguchi², Takayuki Inoi³, Haruichi Kanaya¹, ¹Kyushu University, ²ALSENSE, ³Yamagata University / Japan, ⁴Electronics Research Institute / Egypt</p>	<p>TE4: Tomoka... TE4-1 <Sessio... Updated Stat... Packaging &... Tanja Braun, F... Germany</p> <p>TE4-2 <Sessio... Printing in th... Charles E. Ba...</p> <p>TE4-3 <Sessio... Updated R&I... Technology in... Yoshihisa Kat...</p> <p>TE4-4 <Sessio... Future Activi... Technology in... Hisao Kasuga... Research Asso...</p>

12:30					
	Lunch Time				
13:30	<p>FA3: Fan-out Packaging Technology-2 FA3-1 <Session Invited> Fan-out Wafer Level Packaging for 5G and mm-Wave Applications Tanja Braun^{1,2}, Karl-Friedrich Becker², Ole Hoelck¹, Ruben Kahle¹, Markus Woehrmann¹, Michael Toepper¹, Ivan Ndip¹, Uwe Maass¹, Christian Tschoban¹, Rolf Aschenbrenner¹, Steve Voges², Klaus-Dieter Lang², ¹Fraunhofer IZM, ²Technical University Berlin / Germany</p> <p>FA3-2 <Session Invited> Development of Liquid Compression Molding Material (LCM) for Low Warpage Tsuyoshi Kamimura¹, Satomi Kawamoto¹, Daisuke Hashimoto¹, Haruyuki Yoshii¹, Hidetoshi Inoue², ¹Namics, ²Hitachi Chemical / Japan</p> <p>FA3-3 <Session Invited> Temporary Adhesive and Equipment Solutions for Fan-out WLP/PLP Technology Akihiko Nakamura, Tokyo Ohka Kogyo / Japan</p> <p>FA3-4 UV Laser Releasable Temporary Bonding Materials for FO-WLP Hikaru Mizuno, Hiroyuki Ishii, Hitoshi Kato, Takashi Mori, Hiroki Ishikawa, Yooichiroh Maruyama, Kenzo Ohkita, Koichi Hasegawa, JSR / Japan</p>	<p>FB3: Emerging Technologies-4 FB3-1 Flexible Substrate with Movable Device Island Supported by Serpentine Interconnect for Mounting Ultra-thin Silicon Chips Takeshi Kobayashi, Toshihiro Takeshita, Yusuke Takei, Ryohei Takei, National Institute of Advanced Industrial Science and Technology / Japan</p> <p>FB3-2 Fully-printed Vertical Interconnections with Tapered Contact Holes Formed by Vapor-annealing Technique Yasuyuki Kusaka, Shusuke Kanazawa, Hirobumi Ushijima, National Institute of Advanced Industrial Science and Technology / Japan</p> <p>FB3-3 Reliability Analysis of SiP Module Board Level Bending Test Wei-Hong Lai, Shao-Chen Yen, Hsin-Chih Shih, Meng-Kai Shih, David Tarng, Chih-Pin Huang, Advanced Semiconductor Engineering / Taiwan</p> <p>FB3-4 Void Reduction in Reflow Soldering Processes by Sweep Stimulation of PCB Substrate Viktoria Rawinski, Erska / Germany</p>	<p>FC3: Power Electronics Integration-1 FC3-1 <Session Invited> Power Device Applications of Ga2O3 Kentaro Kaneko¹, Takashi Shinohe², Shizuo Fujita¹, ¹Kyoto University, ²FLOSFIA / Japan</p> <p>FC3-2 SiC Power Module for Motor Driving System Chun-Kai Liu¹, Chih-Ming Tzeng¹, Rong-Chang Fang¹, Chih-Wei Li², James Goo³, ¹Industrial Technology Research Institute, ²LINGSEN Precision, ³Shihlin Electric / Taiwan</p> <p>FC3-3 Failure Mode Verification of Power IGBT under Different Thermal Stress Application Conditions in Power Cycling Test Environment Qun Yuan¹, Ryo Endoh², Tetsuya Ima³, Yasushi Kajita⁴, Yafei Luo¹, ¹Mentor Graphics Japan, ²Toray Research Center, ³Yamaha Motor, ⁴Nagoya Municipal Industrial Research Institute Industrial Research Institute / Japan</p> <p>FC3-4 Metallization Technology of SiC Power Module in High Temperature Operation Tomohito Iwashige¹, Kazuhiko Sugiura¹, Takeshi Endo¹, Kazuhiro Tsuruta¹, Yuich Sakuma², Seigo Kurosaka², Yukinori Oda², Chuantong Chen³, Shijo Nagao³, Katsuaki Suganuma³, ¹Denso, ²C. Uyemura, ³Osaka University / Japan</p>	<p>FD3: Materials and Processes: advanced process FD3-1 <Session Invited> New Market Trend in CMP Equipment / Material for the " More than Moore" era Yasuhiko Takeno¹, Kazuya Okamoto², ¹Global Net, ²Yamaguchi University / Japan</p> <p>FD3-2 Investigation of the Laser Ablation Threshold for Optimizing Laser Direct Structuring in the 3D-MID Technology Li Wang, Robert Suess-Wolf, Michael Ulm, Joerg Franke, Friedrich-Alexander University Erlangen-Nuremberg / Germany</p> <p>FD3-3 Rapid Laser Drilling on Thick Ceramic Substrates for SiP Applications Shih-jeh Wu¹, Hsiang-Chen Hsu^{1,2}, Wen-Fei Lin¹, Boen Hung¹, Yeh Chang¹, ¹I-Shou University, ²St. John's University / Taiwan</p> <p>FD3-4 Investigation of the Differences in Nanometric Grinding of SiC and Si by Molecular Dynamics Miaocao Wang¹, Fulong Zhu¹, Yixin Xu¹, Sheng Liu^{1,2}, ¹Huazhong University of Science and Technology, ²Wuhan University / China</p>	<p>FE3: Optoelectronics FE3-1 <Session Invited> Toward Coincidence Detection of Single Photon Polymer for C Okiihiro Sugihara, National Institute of Advanced Industrial Science and Technology / Japan</p> <p>FE3-2 <Session Invited> Multimode / Single-mode Waveguides for On-chip Takaaki Ishiguro, National Institute of Advanced Industrial Science and Technology / Japan</p> <p>FE3-3 <Session Invited> High-density Silicon Photonics Tsuyoshi Aoki, National Institute of Advanced Industrial Science and Technology / Japan</p> <p>FE3-4 Process Development of Sintered High-conductivity and Flip Chip Alexander Harbeck, Krishna Bhogal, Elger¹, ¹Technische Universität München, Germany, ²University of Applied Sciences / Germany</p>
15:10					
	Break				
15:30	<p>FA4: Fan-Out Packaging Technology-3 FA4-1 Highly Reliable Low Temperature Curable Photosensitive Polyimide Masao Tomikawa, Yuki Masuda, Yu Shoji, Kazuyuki Matsumura, Ryoji Okuda, Toray Industries / Japan</p> <p>FA4-2 Modeling of Cure Kinetics of Molding Compound and Its Effects on Drag Force in Compression Molding Chia-Heng Chung¹, Hsien-Chie Cheng², Wen-Hwa Chen¹, ¹National Tsing Hua University, ²Feng Chia University / Taiwan</p> <p>FA4-3 Mechanical Characterization Comparison as Flip-Chip Package to Fan-Out Package Dao-Long Chen, Po-Hsien Sung, Wei-Jie Yin, Meng-Kai Shih, David Tarng, Chih-Pin Hung, Advanced Semiconductor Engineering / Taiwan</p>	<p>FB4: Medical & Healthcare-2 FB4-1 <Session Invited> Peripheral Nerve Detection Probe by Raman Spectroscopy Yasuaki Kumamoto, Tetsuro Takamatsu, Kyoto Prefectural University of Medicine / Japan</p> <p>FB4-2 <Session Invited> Smart Environment Sensor for Healthcare Applications Naotsugu Ueda, Rysuke Sakai, Hiroyuki Mino, OMRON / Japan</p> <p>FB4-3 Fundamental Study to Evaluate Walking Skill of Visually Impaired Person Hiroaki Inoue¹, Shunji Shimizu¹, Toshiya Tsubota¹, Tatsuo Hisaoka¹, Yoshikazu Seki², ¹Tokyo University of Science, Suwa, ²National Institute of Advanced Industrial Science and Technology / Japan</p> <p>FB4-4 Noncontact Heart Rate Measurement System on Single Board Computer Daisaku Ikoma¹, Yuya Abe¹, Naoki Kawazu¹, Hideharu Toda¹, Masatoshi Sato², Hisashi Aomori¹, ¹Chukyo University, ²Tamagawa University / Japan</p> <p>FB4-5 Development of an Automatic Urine Monitoring Device using Cross-selectivity Sensing Principle Benjamin Ioller, Norihisa Miki, Keio University / Japan</p>	<p>FC4: Power Electronics Integration-2 FC4-1 <Session Invited> Semiconductor Package Technologies in J-Devices for Automotive Application Akio Katsumata, Akito Yoshida, Akinori Ono, Nobuaki Oie, Toru Takahashi, Fumihiko Taniguchi, J-Devices / Japan</p> <p>FC4-2 A highly Integrated Copper Sintered SiC Power Module for Fast Switching Operation Bao Ngoc An¹, Dai Ishikawa², Thomas Blank¹, Helge Wurst¹, Horst Demattio¹, Benjamin Leyrer¹, Johannes Kolb³, Torsten Scherer¹, Ansgar Simon⁴, Marc Weber¹, ¹Karlsruhe Institute of Technology / Germany, ²Hitachi Chemical / Japan, ³Schaeffler Technologies, ⁴Infineon Technologies / Germany</p> <p>FC4-3 Cu-Sn Based Die Attach Material for Power Semiconductor with Stress Control Hiroaki Ikeda, Shigenobu Sekine, Ryuji Kimura, Koichi Shimokawa, Keiji Okada, Hiroaki Shindo, Tatsuya Ooi, Rei Tamaki, Napra / Japan</p> <p>FC4-4 A Nearly-perfect Ag Joints Prepared by Novel Ag to Ag Direct Bonding Hao Zhang, Seungjun Noh, Norio Asatani, Yukiharu Kimoto, Aiji Suetake, Shijo Nagao, Tohru Sugahara, Katsuaki Suganuma, Osaka University / Japan</p> <p>FC4-5 A High Efficient Synchronous Rectifier for Next Generation Automotive Alternator Applications K. S. Kao, H. H. Lin, W. K. Han, S. T. Wu, C. M. Tseng, T. J. Yu, P. K. Chiu, Y. T. Lin, S. F.</p>	<p>FD4: Materials for Nanophotonics Devices FD4-1 <Session Invited> (50min) Nanophotonics: a frontier cultivated by microassembly Hideki T. Miyazaki, National Institute for Materials Science / Japan</p> <p>FD4-2 Organic/Inorganic Interfacial Microstructures Achieved by Fast Atom Beam Bombardment and Vacuum Ultraviolet Irradiation Tilo Hongwei Yang^{1,2}, C. Robert Kao¹, Akitsu Shigetou², ¹National Taiwan University / Taiwan, ²National Institute for Materials Science / Japan</p>	

Cancelled

On Material Modelling and Characterization of Thermal Interface Materials

Emad A. Poshtan, Bosch / Germany

Solving Wirebond Sporadic Ball Size on a 2D MCM Package

Ernesto Pentecostes Rafael, Joel De Guzman Raposas, Lora Calaguas Razon, Texas Instrument Philippines / Philippines

Laserbonding Directly on Semiconductor Surfaces: LIMBO process

Josef Sedlmair¹, Benjamin Mehlmann¹, Simon W Britten², Alexander Olowinsky², ¹F&K Delvotec Bondtechnik, ²Fraunhofer IZM / Germany

Cu-Cu Interconnect using Electroless Palladium Plating in High Frequency Application

Ying-Hsuan Chen, Han-Tang Hung, Sean Yang, I-An Weng, C. Robert Kao, National Taiwan University / Taiwan

Electrostatic Characteristics of AlN with Sm2O3 Addition <Session Invited>

Yong-Bin Sun, Chang-Hee Lee, Kyonggi University / Korea

Zero-Balance Method for A Sealed Cavity Pressure Evaluation of Vacuum Packaged Micro-Devices

Muhammad Salman Al Farisi, Hideki Hirano, Shuji Tanaka, Tohoku University / Japan

Impacts of H-Containing HCOOH Vapor Treatment on Cu Micro-Particles

Ran He^{1,2}, Fengwen Mu¹, Zhi Cao², Yinghui Wang², Tadatomu Suga¹, ¹The University of Tokyo / Japan, ²Institute of Microelectronics of Chinses Academy of Sciences / China

Poster Session

Poster sessions wil be held from 14:50-15:50 on April 18 and from 15:10-16:10 on April 19.

P01	Effect of W Addition for Cu Diffusion Barrier Property of Electroless CoB Films Formed on SiO₂ Takaki Iseri ¹ , Shusuke Shindo ¹ , Tomohiro Shimizu ¹ , Takeshi Ito ¹ , Moriji Matsumoto ² , Shoso Shingubara ¹ , ¹ Kansai University, ² JCU / Japan
P02	Batch Microwave Plasma Cleaning for Robustification of Automotive Devices Ghizelle Jane Estrada Abarro, Rod Delos Santos, Darwin De Lazo, Alvin Denoyo, Ariel Tan, Manny Ramos, ON Semiconductor Philippines / Philippines
P03	Multi-chip Gang Bonding Technology Using the Thermo-compression Bonder for Si Substrate Noboru Asahi, Yoshihito Mizutani, Koichi Imai, Hiroto Tanaka, Yasunori Hashimoto, Toshiyuki Jinda, Mikio Kawakami, Katsumi Terada, Toray Engineering / Japan
P04	Loop Height Assessment for Automotive Package Mohd Izzuddin Suboh, Mohamad Syahirul Syafiq Ali, Infineon Technologies (Malaysia) / Malaysia
P05	Material Characterization in TSV Fabricated by Supercritical Carbon Dioxide Electroplating Ho-Chiao Chuang ¹ , Guan-Wei Jiang ¹ , Ai-Ho Liao ² , ¹ National Taipei University of Technology, ² National Taiwan University of Science and Technology / Taiwan
P06	Flexible and Transparent Silver-grid Over-coated with PEDOT: PSS electrode prepared by gravure offset printing Masato Ohsawa, Natsuki Hashimoto, ULVAC / Japan
P07	A Study of the Anodizing of Titanium for Dye-sensitized Solar Cells Yu-Wen Chen, Chih-Ming Chen, National Chung Hsing University / Taiwan
P08	Preparation of Vitamin C Doped Polymers for Physical Characteristics Using Electrospinning Process Sheng-Hung Shih, Chun-Yi Chen, Cho-Liang Chung, I-Shou University / Taiwan
P09	Enhancement of Electrical Conductivity Developed in an Epoxy-based Adhesive with Silver Flakes Loading Tomohito Negishi, Masahiro Inoue, Gunma University / Japan
P10	Preparation of Superhydrophobic Silicon-Based Net-like Hollow Nanostructure Using Electrospinning Jui-Wen Liang, Wen-Yu Wang, Cho-Liang Chun, I-Shou University / Taiwan
P11	Variation in Electrical Conductivity of Air-curable Copper Pates Composed of a Phenolic-based Binder during Soaking in Several Environments Kenta Kawarai, Masahiro Inoue, Gunma University / Japan
P12	Creation and Functional Control of Metal Nanoparticle-Polymer Interface by Laser Plasma EUV Light Excitation Kiyokazu Yasuda, Nozomi Tanaka, Nao Wada, Hiroaki Nishimura, Osaka University / Japan
P13	First Principles Calculation of the Structure and Quantum Capacity of Acidic Functional Groups on Graphene-based Capacitor Bochen Li, Takeyasu Saito, Naoki Okamoto, Osaka Prefecture University / Japan
P14	A Fracture Analysis of Different Cu Electroplated Layers on Ni-metallized Polyimide Film Yi-Hsuan Chen, Shan-Chen Tsai, Chih-Ming Chen, National Chung Hsing University / Taiwan
P15	Variations in Electrical Resistivity of Stretchable Printed Wires Composed a Polyurethane-based Binder Containing Silver Fillers under Cyclic Tensions Yuta Hosono, Masahiro Inoue, Gunma University / Japan
P16	Coupling Model and Non-contact Measurement Approach by Near-field Technology Sheng-Wei Guan ¹ , Chih-Wen Kuo ¹ , Cheng-Tao Li ² , Sung-Mao Wu ² , ¹ National Sun Yat-sen University, ² National University of Kaohsiung / Taiwan
P17	Effect of Au Thickness on Bonding Reliability for Silver Coated Au Bonding Wire Xiangqing Yang, HeNan Polytechnic University / China

P18	Feasibility Study of All-SiC Pressure Sensor Fabrication without Deep Etching Fengwen Mu ¹ , Yechao Sun ^{2,4} , Haiping Shang ² , Yinghui Wang ^{2,3,4} , Tadatomo Suga ^{1,3} , Weibing Wang ^{2,4} , Dapeng Chen ^{2,4} , ¹ The University of Tokyo / Japan, ² Institute of Microelectronics Chinese Academy of Sciences, ³ Kunshan Branch, Institute of Microelectronics of Chinese Academy of Sciences, ⁴ University of Chinese Academy of Sciences / China
P19	Reduction of Parasitic Capacitance of Flexible Tactile Sensors Tatsuho Nagatomo, Norihisa Miki, Keio University / Japan
P20	Electrodeposition of ZnS and Evaluation of Its Optical Property Naohiro Matsuda, Naoki Okamoto, Takeyasu Saito, Osaka Prefecture University / Japan
P21	Synthesis and Thermal Conductivity of Carbon Nanotube (CNT)/Polymer Composites Chih-Feng Wang ¹ , Pei-Kang Huang ¹ , Yi-Jung Tsai ¹ , Chih-Lin Wu ¹ , Yan-Yu Chang ¹ , Kuo-Jung Lee ¹ , Ping-Feng Yang ² , ¹ I-Shou University, ² Advanced Semiconductor Engineering / Taiwan
P22	Synthesis and Thermal Conductivity of Expanded Graphite (EG)/Polymer Composites Chih-Feng Wang ¹ , Pei-Rung Hung ¹ , Chih-Lin Wu ¹ , Yi-Jung Tsai ¹ , Yan-Yu Chang ¹ , Kuo-Jung Lee ¹ , Ping-Feng Yang ² , ¹ I-Shou University, ² Advanced Semiconductor Engineering / Taiwan
P23	Development of Novel AlN Filler for High Thermal Conductivity Packaging Material Yukihiro Kanechika, Akimasa Kuramoto, Yutaka Fukunaga, Yasushi Imoto, Yoshitaka Inaki, Saiko Fjii, Meng Wan, Teruhiko Nawata, Masahide Ueda, Tokuyama / Japan
P24	Evaluation of Thermal Resistance of Various Thermal Grease Shinya Seki, Ryo Endoh, Masaaki Takeda, Toray Research Center / Japan
P25	Evaluation of Thermal Cycle Stress in SiC Power Devices by Raman Spectroscopy Tomoyuki Uchida, Ryuichi Sugie, Toray Research Center / Japan
P26	Thermal Conductivity Measurement of Diamond and β-Ga₂O₃ Thin Films by a 3ω Method Shinichiro Suzuki ^{1,2} , Shinya Ohmagari ² , Yusuke Akutsu ¹ , Naoki Okamoto ¹ , Takeyasu Saito ¹ , Hitoshi Umezawa ² , Yoshiaki Mokuno ² , ¹ Osaka Prefecture University, ² The National Institute of Advanced Industrial Science and Technology / Japan

Cancelled

The Geometric Approach on Enabling Angular Die Bonding Process

Ernesto Pentecostes Rafael, Dolores Babaran Milo, Texas Instrument Philippines / Philippines

Leadframe Design Resolution to Eliminate Bsm Risk of Leakage and Metal Shorting

Dolores Babaran Milo, Texas Instrument Philippines / Philippines

BAMFIT – Bond Accelerated Mechanical Fatigue Interconnect Test

Josef Sedlmair¹, Bernhard Czerny², Golta Khatibi², ¹F&S Bondtec Semiconductor, ²Technical University Vienna / Austria

Package-in Temperature Measuring with Micro-heater Soldering for Pyroelectric IR Sensor

Hideaki Mizusaki^{1,2}, Toshiro Sato², Makoto Sonehara², ¹Nagano Prefecture General Industrial Technology Center, ²Shinshu University / Japan

Wire Bond Design and Process Simulation for Optimum Wire Bond Interconnect

Chee Meng Chai, Chan Lam Cha, Infineon Technologies Asia Pacific / Singapore

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